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What do we know about the Defect Types detected in Conceptual Models?

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Abstract—In Model-Driven Development (MDD), defects are managed at the level of conceptual models because the other artefacts are generated from them, such as more refined models, test cases and code. Although some studies have reported on defect types at model level, there still does not exist a clear and complete overview of the defect types that occur at the abstraction level. This paper presents a systematic mapping study to identify the model defect types reported in the literature and determine how they have been detected. Among the 282 articles published in software engineering area, 28 articles were selected for analysis. A total of 226 defects were identified, classified and their results analysed. For this, an appropriate defect classification scheme was built based on appropriate dimensions for models in an MDD context.

Keywords— Conceptual Schema Defects, Defect Classification Scheme, Systematic Mapping Study, Model-Driven Development

I. INTRODUCTION

Unlike in traditional Software Development where the software is the main artefact, in Model-Driven Development (MDD) the main artefact is a model (conceptual schema -CS¹). Instead of building and rebuilding software through programming, during MDD the Conceptual Schemas are extended and transformed into other models to build the software product using code-generation strategies.

CSs are developed using a modelling language. The de-facto standard for analysis and design of object-oriented software systems is the Unified Modelling Language (UML) [1] [2], which is extended with OCL (Object Constraint Language) constraints [3]. The variety of UML diagrams provide flexibility and applicability to modellers to create CSs in the different spaces where they can be used (problem, solution and background) [4]. However, since the modelling process is a human task, it is difficult to avoid introducing defects into the CSs (e.g. inconsistency, incorrect, redundant and imprecise elements).

Although defects may be inevitable, we should minimize their number and impact on software quality through testing and/or inspecting the CS. Information on the defect types that occur in the earlier stages of the software development life cycle can be used to give feedback to stakeholders (e.g. modellers, developers, testers) about detecting defects and how they can be tracked, reduced and resolved. Moreover, if the purpose is to get a good quality CS, the information on each defect must be related to the quality goals affected, according to an appropriate quality model for models in a MDD context, as proposed in [5].

Defect classification schemes define a set of attributes², attribute values and a process to classify the defects. Freimut [6] claims that "Defect classification schemes can differ in the way different attributes or attribute values relate to each other". For example, for indicating the location of a defect in code, a program line number will suffice. For a UML model, the defect is recognized by referring to the element (i.e. class name) and the diagram name. So far, existing defect classification schemes (e.g. HP scheme [7], Orthogonal Defect Classification (ODC) by Chillarege [8] and IEEE std. 1044 [9]) are not appropriate for CSs because they were designed for other contexts (e.g. for defects at implementation and code level), giving rise to the need for adaptations [10], [9]. Few attempts can be found in the literature to classify defects in CSs [11], [12], [13], [14], [15], $[PS1]^3$ and [PS21]. However, none of these uses a defect classification scheme to systematically capture the defect information (e.g. description, affected quality goal, technique type) in order to classify the defects and identify the group to which it belongs.

The objective of the study described in this paper is to get an overview of the type of defects that are reported in the literature at the conceptual schema level and determine how they have been detected. Therefore, we first build a classification scheme for CS defects based on standard classification schemes to extract clear and complete information on defect types that occur in CSs. Subsequently, we executed a mapping study to obtain an overview and categorize the information published in relation to defect classifications and/or taxonomies. In this paper, we present the results of our systematic mapping study based on guidelines proposed by Kitchenham et al. [16] and Petersen et al. [17]. This work is part of a more extensive research study, whose main goal is to develop an approach for testing-based conceptual schema validation in a Model-Driven Environment

¹ A conceptual schema is a description, representation or definition of the knowledge that is needed by an information system (requirements) to perform its functions [25]. In this work the terms "conceptual schema", "conceptual model" and "model" are considered similar.

 $^{^2}$ $\,$ In this paper, the term attribute is used to refer to a feature or property of a defect.

³ References beginning with "P" refer to primary studies covered in this mapping study as given in Appendix II.

[18], [19]. This work particularly focuses on CSs in UML-based systems.

The remaining parts of this paper are organized as follows: Section 2 presents the background on CS quality models. Section 3 summarizes the process of building a classification scheme for CS defects. Section 4 describes the method used in conducting the mapping study. Section 5 discusses the results of this review and defect classification. Section 6 presents the limitations of this study. Finally, Section 7 presents the conclusions and future work.

II. BACKGROUND: QUALITY MODELS FOR CONCEPTUAL SCHEMAS

Different quality models can be found in the literature for describing the quality of CSs (e.g. [20], [21], [4] and [22]). In the present paper we have chosen Mohagheghi et al. [5] as a reference because they describe a quality model oriented to Model Driven Engineering (MDE). Their model takes into account that an MDD approach automates many activities in software development, and consequently CSs in MDD are expected to get progressively more complete, precise and executable such that in the end they can be used to generate the code and other artefacts such as test cases. MDD therefore adds new requirements to the development process such as consistency between models, technical comprehension by tools and support changes. They perform a combination of several quality models and identify the following six classes (6C) of CS quality goals, as follows (see Table I).

 TABLE I.
 QUALITY GOALS (BASED ON 6C QUALITY MODEL FROM MOHAGHEGHI ET AL. [5])

	Monikoneon er ne. [9])
Quality Goal (QG)	Description
Correctness QG1	Including correct elements and relations between them, and including correct statements about the domain; not violating rules and conventions; for
	example adhering to language syntax. Thus it covers both syntactic correctness (right syntax or
	well-formedness) and semantic correctness (right meaning and relations relative to the knowledge
	about the domain).
Completeness QG2	Having all the necessary information that is relevant and being detailed enough according to the purpose of modelling. It is a semantic quality.
Consistency	Having no contradictions in the models, related to
QG3	syntactic quality. It covers consistency between
	views that belong to the same level of abstraction
	or development phase (horizontal consistency), and
	between views that model the same aspect, but at different levels of abstraction or in different
	development phases (vertical consistency). It also
	covers semantic consistency between models; i.e.
	the same element does not have multiple meanings in different diagrams or models.
Comprehensibility	Being understandable by the intended users, either
QG4	human users or tools. It is related with the pragmatic quality.
Confinement	Being in agreement with the purpose of modelling
QG5	and the type of system, and being restricted to the
	modelling goals; such as including relevant
	diagrams and being at the right abstraction level. It is related with the semantic quality.
Changeability	Supporting changes or improvements so that
QG6	models can be changed or revolved rapidly and
	continuously. It is related with the pragmatic quality.
	quanty.

Our paper considers the aforementioned quality goals and relations between them to classify CS defects and analyse the results.

III. CLASSIFICATION SCHEME FOR CONCEPTUAL SCHEMA DEFECTS

In order to address the goal of our work we first needed to define a defect classification scheme (DCS) previously to data extraction of the literature. This process was conducted in the following three stages:

A. Establish a list of Defect Causes

First, we needed to establish a list of defect causes that enables the classification and documentation of a found defect.

We decided to define the defect causes at a coarse-grained level by taking the modes from the IEEE standard [9], i.e. missing, wrong and unnecessary. Then, in order to relate the cause of the defects with affected quality goals proposed by Mohagheghi et al. [5], we specified sub modes (types) of the defects related to the quality goals affected by them (see Table II). These sub modes are based on definitions from [9], [7], [23], [11], [PS8] and [PS26], and have been adapted to CSs.

 TABLE II.
 DEFECT TYPES BY MODE AND THEIR RELATION WITH THE QUALITY GOALS

Mode	Sub modes	Affected
(defect cause)		QG
MISSING	Missing	QG2,
Something is	-	QG4
absent that should		
be present [9].		
WRONG	Inconsistent: There are contradictions	QG1,
Something is	in the models (vertical and horizontal	QG3,
incorrect,	inconsistency) [9], [PS8], [PS26].	QG4,
inconsistent or		QG5
ambiguous [9].	Incorrect: There is a misrepresentation	QG1,
	of modelling concepts, their attributes	QG4
	and their relationships, as well as the	
	violation of the rules by combining of	
	these concepts at the time of building partial or complete models [9], [7], [11],	
	[23].	
	Ambiguous (wrong wording): The	0G1,
	representation of a concept in the model	OG3
	is unclear, and could cause a user	200
	(modeller, low-level designer, etc.) to	
	misinterpret or misunderstand the	
	meaning of the concept [9], [23], [11].	
UNNECESSARY	Redundant: If an element has the same	QG5
(Extra)	meaning that other element in the	
Something is	model.	
present that need	Extraneous: If there are items that	QG5,
not be [9].	should not be included in the model	QG6
	because they belong to another level of	
	abstraction (e.g. details of	
	implementation) [23], [11].	

B. Construct a Defect Classification Scheme

Following a slight adaptation of the process proposed by Freimut [6], we started by identifying those attributes that were considered important to register and classify, once a defect was found in a CS. We used terminology aligned with UML concepts [2] (modelling language used for building the CSs) and based on the standard IEEE classification [9] and its guide [24].

First, we adjusted the description of the scope of the relationships between conceptual entities proposed by the standard IEEE on the one side, with the conceptual entities of our study (UML-based conceptual models) on the other. This resulted in Fig. 1, where these relationships are depicted graphically. The red frame directly corresponds to the IEEE standard.

Looking at Fig. 1, a conceptual schema represents the (software) systems requirements at an abstract level. It may consist of several UML diagrams (structural and behavioural), where each diagram type contains different type (modelling element) of information about the system. Additionally, the conceptual schema has associated quality properties that support the representation or description of the requirements. These quality properties usually are threatened by defects that occur at the diagrams elements level of the conceptual schema.

A defect may be associated with a single Corrective Change Request of the Conceptual Schema, which attempts to resolve the defect and each Corrective Change Request may be associated with, at the most, a single Conceptual Schema Release. The Fig. 1 also represents the other two causes of Conceptual Schema Changed Request (CSCR), perfective change request of conceptual schema and adaptive change request of conceptual schema.

Additionally, the defects at conceptual level can be located in several ways through V&V techniques, which use a detection mechanism (based on rules, metrics, and modelling conventions) for this purpose. According to the technique nature, this can be static or dynamic supported by a tool and they can have different scope depended on its purpose (i.e. detect, prevent and resolve).

Finally, the defects have insertion activity, severity, priority and probability of occurrence. They are detected at any specific time by noticing specific description (symptom), using detection mechanism. Each of these aspects is relevant for the purpose of required analysis and also allows a classification of defects.

Based on this analysis, we took some attributes from the standard IEEE and adapted them to the context of UML-based models, then added attributes required in this study (i.e. technique purpose, technique type and tool support and detection mechanism). Table XI (see Appendix I) documents the mapping between attributes of the proposed classification scheme and provided by the standard IEEE. Once we finished this mapping, we could document the attributes and attributes values.

The set of values for each attribute was obtained from definitions of Table II (i.e. defect cause, sub mode), UML definitions (i.e. modelling element, diagram level and diagram type), standard IEEE (i.e. priority) and defects found in the literature (i.e. detection mechanism, tool support and references).

The final classification scheme was compiled and depicted in the Table III with the description and attribute values to each scheme attribute.

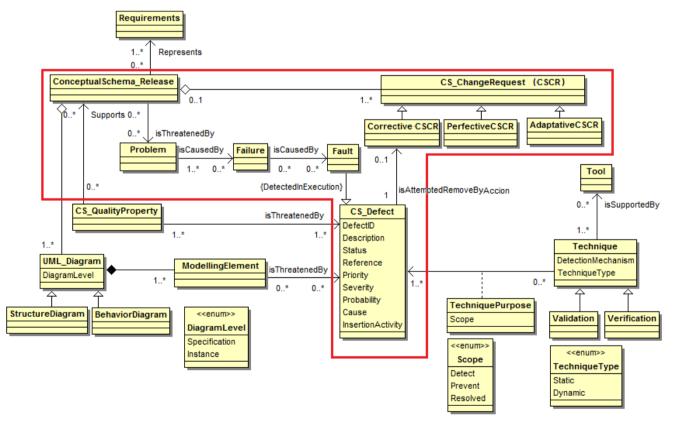


Fig. 1. Relationships modeled for understanding the relationships among conceptual entities used in Classification Scheme Structure (adapted from [9])

TABLE III. ATTRIBUTES OF DEFECT CLASSIFICATION SCHEME

Attribute	Description	Attribute Values
Defect	A categorization based on	Missing, wrong or
Cause	Table II.	unnecessary (see Table II).
(Mode)		
Sub mode	A categorization at a fine-	Missing, inconsistent,
	grained level of the defect	incorrect, ambiguous,
	causes.	redundant or extraneous (see
		Table II).
Defect ID	Unique identifier for the	DX.Y, X=sub mode (1-6),
	defect.	Y=sequential number that
		identifies the defect within the
		sub mode.
Description	The term or phrase used	Short phrase using words
1	to describe the defect of	according to defect causes (see
	the CSs.	Table II)
Modelling	The design entities	Element of UML diagrams
Element	involved in the defect.	(e.g. classes, relationships,
		operations, objects, messages).
Diagram	These levels are	Specification= This level
Level	according the UML	contains elements that
	diagrams [2].	represent specifications for
	_	instances, such as classes,
		associations and messages.
		<i>Instance</i> = The instance level
		contains instances for
		diagrams elements such as
		objects and links.
Diagram	It is a categorization	e.g. Use Case (UC), class
Туре	based on the diagram	diagram (CD), object diagram
	within which the defect is	(OD), sequence diagram (SD),
	found. A distinction	communication diagram
	between behaviour	(CoD), activity diagram (AD),
	diagrams and structure	state machine diagram
	diagrams is performed.	(<i>STMD</i>) and package diagram
D: :/		(<i>PD</i>).
Priority	Describes the defect	High (H), Medium (M) and
g ''	priority.	Low (L). Critical = a defect that will
Severity	Describes the severity of	
	a resulting or potential	cause the model execution to
	failure with respect to CS. Various levels of severity	crash, stop or close abruptly. <i>Medium</i> = a defect, which will
	can be found in the	cause an observable failure or
	primary studies. A	breach of requirements.
	translation to the	Low = a defect that will not
	following terms is	Low = a defect that will not cause a failure in execution of
	required.	the CS.
Technique	Whether to detect the	Static (S) = execution is not
Туре	defect execution of the	required.
1,160	CS is required or not.	Dynamic (D) = execution is
	construction of not.	required.
Detection	Detection mechanism	The word o words used to
Mechanism	name used by the	name the detection
	detection technique.	mechanism.
Tool	Tool name used for	The word o words used to
Support	detecting process.	name the tool support.
References	List of references	Source ID =[PSn]

C. Definition of the Defect Classification Process

To classify the defects found in the selected literature, we made a list of questions based on the defect classification process adapted from IEEE [24]. This process basically consists of three steps: (a) identifying the attribute information, (b) classifying the attribute information, and (c) recording the attribute values of the defect. Our process basically defines a user guide with questions previously formulated for the person

recording the defect and that can be conducted along the classification process by answering each question and at the end get the possible location of the defect within the structure of the scheme classification (see Table IV). The attributes defect identifier (Defect ID) and mode (defect cause) are assigned later based on the sub mode value of the defect.

TABLE IV.	QUESTIONS FOR CLASSIFYING THE DEFECT
-----------	--------------------------------------

		<u> </u>
Steps of Defect Classification Process	Attribute Name Question	
Defect Recognition	Sub mode	What is missing, inconsistent, incorrect, ambiguous, redundant, or extraneous?
	Description	How did the defect manifest itself? (e.g. missing class)
	Modelling Element	Which diagram element contains the defect? (e.g. class, association, message)
	Diagram Level	What does level of the diagram is affected? (specification or instance)
	Diagram Type	Which diagram contained the defect? (e.g. CD, SD)
	References	Where (paper) was reported the defect? (e.g. PS8)
Impact Identification	Priority	What is the importance of resolving the defect?
	Severity	How severe is the defect with respect to quality of conceptual schema? (e.g. high, medium)
Detection Investigation	Technique Type	Which type of technique can detect it? (e.g. static)
	Detection Mechanism	Which is the detection mechanism used by the technique? (e.g. automated inspection, checking consistency rule)
	Tool Support	What does tool can detect/resolve/prevent it? (i.e. tool name)

IV. DESIGN OF THE MAPPING STUDY

The main steps in conducting a mapping study are discussed in the following subsections.

A. Defining the Research Questions

As mentioned in Section 1, this paper focuses on summarizing and classifying the CS defects reported in the literature. The CSs we consider are focussed on information systems design based on UML. Therefore, this work answers the following research questions (RQs):

- RQ1: What defects in UML-based CSs are reported in the literature?
- RQ2: How and where have these defects been detected?

B. Search Strategy for Selection of Primary Studies

A Systematic mapping was conducted for a period of three months (October to December/2014). SCOPUS^{™4} was used as the search engine, as it provides access to well-known bibliographic-databases such as IEEExplore, SpringerLinks and

ACM Digital Library, etc. A search string was created based on keywords extracted from the research questions and augmented with synonyms. After iterative refinement, the definitive search string was:

SS: (defects OR faults) AND (UML model OR UML design OR UML diagram)

Executing the search string in SCOPUSTM on article title, abstract and keywords the result was an extensive list of candidate papers for the review.

We restricted these preliminary search results by limiting the subject area to computer science and the document type to conference paper, article and book chapter in English. To ensure that only relevant studies were included, sets of inclusion and exclusion criteria were defined (see Table V).

TABLE V.	INCLUSION AND EXCLUSION CRITERIA	

Inclusion criteria	Exclusion Criteria
I1. Papers about defects	E1. Papers that do not comply with the
or faults in CSs based on	inclusion criteria presented.
UML in particular and	
how or where defects	
have been detected.	
I2. Studies available	E2. Informal literature e.g. editorials,
online.	keynotes, introductions to/abstract, posters and
	slides alone.
I3. Studies written in	E3. Duplicated reports (the most complete
English.	version of the work was included in the
	review).

A two-phase selection process was performed as follows:

1) In the first search phase, based on the titles, keywords and abstracts, irrelevant papers were excluded. A total of 28 papers were identified in this phase.

2) In the second search phase, we read the remaining papers and eliminated any that were not related to the research question and identified 11 papers. However, in this phase 53 additional studies were located by scanning the references and grey literature (e.g. technical reports and theses) for any other candidate primary sources. The two selection phases were again applied and a further 17 papers were added the list.

We identified a total of 28 primary studies (see Table VI).

Search	# of hits	Phase 1 (titles, keywords and abstracts)	Phase 2 (full text)	Papers selected
SS	282	28	11	[PS2] [PS3] [PS4] [PS15] [PS16] [PS21] [PS22] [PS24] [PS25] [PS27] [PS28]
Additional from References		53	17	[PS1] [PS5] [PS6] [PS7] [PS8] [PS9] [PS10] [PS11] [PS12] [PS13] [PS14] [PS17] [PS18] [PS19] [PS20] [PS23] [PS26]
Total	282	81	28	

TABLE VI. SELECTED PAPERS IN EACH PHASE OF SYSTEMATIC MAPPING

Table XII, provides a list the selected studies numbered from PS1 to PS28. This table is given in Appendix II. These results include 5 journal papers, 3 workshops, 19 conference papers and 1 Ph. D thesis. There are 4 primary studies on industrial evaluation, i.e. [PS15], [PS16], [PS17] and [PS18], the others were generated in the academic area.

Fig. 2 shows the yearly distribution of primary studies found in the literature, where 2006 is the year with more papers reporting CS defects.

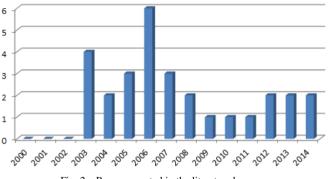


Fig. 2. Papers reported in the literature by years.

C. Data Extraction

In this step we used the proposed classification scheme (see section III) to classify the CS defects reported in the literature.

In this way 226 reported defects were identified and classified in 100 different defects.

All the rows of Table III were stored on a spreadsheet, which was used as the prototype tool for storing and analysing defect data.

An overview of this defect list is given in Table XIII (see Appendix III) in which some attributes (i.e. sub mode, diagram level, severity, detection mechanism and tool support) were omitted due to space restrictions.

The complete list of defects can be accessed through the URL http://users.dsic.upv.es/~nelly/defects.htm.

V. REVIEW RESULTS

This section deals with the results of the systematic mapping study based on the 28 papers selected. The results are structured based on the Research Questions given in Section IV.

A. RQ1: What defects in UML-based CSs are reported in the literature?

By using the attributes of our defect classification scheme (e.g. defect cause, modelling element), several groups of defects were identified. In order to answer this question, we counted the number of papers that reported each defect type. The frequency by defect type is given in Table VII.

From these results we can see that the most commonly reported defect is the "Wrong" type, with 182 defects (81%), the

most frequently reported sub-types (modes) are: Incorrect (95 defects, 42%) and Inconsistent (75 defects, 33%). Extraneous is the least frequently reported (6 defects). The least reported defect type is "Missing", with 18 defects (8%). In the "Unnecessary" defect type, the sub mode Extraneous is the least reported (6 defects, 3%) in comparison to the redundant sub-type (mode).

TABLE VII.	NUMBER OF DEFECT TYPES OF CSS RELATED TO AFFECTED
	QUALITY GOAL

Mode		Sub modes		Affected Quality Goal
MISSING	= 18	Missing	= 18	QG2, QG4
	defects		defects	
WRONG	= 182	Inconsistent	= 75	QG1, QG3,
	defects		defects	QG4, QG5
		Incorrect	= 95	QG1, QG4
			defects	
		Ambiguous	= 12	QG1, QG3,
			defects	
UNNECESSARY	= 26	Redundant	= 20	QG5
	defects		defects	
		Extraneous	= 6	QG5, QG6
			defects	
TOTAL	226		226	
	defects		defects	

We also analysed the relation of these defect types to the quality goals proposed by Mohagheghi et al. [5]. Fig. 3 shows an overview of these results, in which Correctness (QG1) and Comprehensibility (QG4) are the quality properties with most types of identified defects in the mapping study. This could possibly be due to the fact that these quality properties are the most defect-prone at the conceptual schema level, and their correction could reduce the number of other defects such as Completeness (QG2), Consistency (QG3), Confinement (QG5) and Changeability (QG6). However, it could also be due to the support tools used in these papers mostly covering only these defect types.

Finally, since a paper could report more than one defect, we found that the paper from which most defects could be extracted was [PS1] (25 defects) and the least was [PS27] with 1 defect.

B. RQ2: How and where have these defects been detected?

We have identified 12 different defect detection mechanisms (DM) in the primary papers:

- M1: Analysis based on descriptive logic
- M2: Analysis of the dependency graph + reasoning procedure based in logic
- M3: Automated inspection
- M4: Checking consistency rules
- M5: Checking OCL constraints
- M6: Manual inspection of the models
- M7: Analysis on graph transformation rules
- M8: Cardinalities algorithm
- M9:Testing by model simulation
- M10:Testing executable forms
- M11:Testing of Testable Design Under Test
- M12: Black-box testing

In Table VIII the input and steps needed for each detection mechanism are summarized. From this table we can see that there is an approach [PS6] that uses two mechanisms (automated and manual inspection) for detecting defects.

In Table IX the found defect detection mechanisms are categorized according to type (Automated or Manual), tools that were used for the automated techniques and CS components.

Most of the defects reported in the CSs (82%) were detected by static techniques (i.e. where model execution is not required). From the static techniques that were used, 61% were automated by tools, while the rest were done manually.

The defect data also reveals that M6 (Manual inspection) is the mechanism with the most reported defects (62), followed by M3 (Automated inspection) (58) (see Fig. 4). On the other hand, M8 (Testing of Testable Design Under Test) found the lowest number of defects (2). These results could be due to the primary studies mostly focusing on a detection mechanism rather than reporting a complete list of defects. To further locate where the defects were found, we analysed the diagrams used to detect them.



Fig. 3. Classification of defect types based on quality goals

TABLE VIII.	STEPS OF THE MECHAMISMS FOR DETECTING CS DEFECTS
-------------	--

DM	Duonoquigitag	Stong (high lovel)
DM M1	Prerequisites Input: CS	Steps (high level) 1. Translate the CS into DL
111	<i>Oracle based on</i> : a collection of predefined	2. For structural inconsistencies, simply query this DL representation of the CS.
	Description Logics predicates that represent structural and behavioural inconsistencies [PS26]	3. For behavioural inconsistencies, before querying, use the UML meta-model to obtain concrete test data to trigger behaviour.
M2	 Input: CS with OCL constraints [PS23]. Oracle based on: the OCL constraints that come with the CS to assess external correctness, i.e. w.r.t. requirements. a set of predefined properties for internal correctness like satisfiability, class liveness, non-redundancy, etc. 	 The CS with its external OCL constraints is translated into a logic representation. Questions are formalized as derived predicates to assess the CS on these external and predefined internal properties. Checking any property on a schema is reduced to checking the satisfiability of derived predicates.
M3	<i>Input</i> : a CS <i>Oracle based on</i> : a set of heuristics that are necessary for the construction of verifiable models and the programmatic extraction of requirements gathered from practical experience (defined in [PS6])	Automated inspection of these heuristics with a dedicated tool, which internal functioning is not further described in the paper [PS6].
	<i>Input</i> : a CS <i>Oracle based on</i> : a set of rules taken from the UML specification, SDMetrics ⁵ y particularidades de C# [PS9]]	 Transform the CS into C# code. Execute the framework for eXecutable UML (FXU) to evaluate the CS behaviour according to the rules.
	<i>Input</i> : a CS <i>Oracle based on</i> : List of common defects described in [PS14]	Evaluate the CS by executing the UMLint tool that is presented in the paper [PS14] and is basically a syntactic UML checker.
	<i>Input</i> : a CS <i>Oracle based on</i> : The SDMetrics ⁵ .	Using a dedicated static UML checker tool named SAAT described in [PS16].
	 Input: a CS Oracle based on: common interactive behavior, like e.g. on all traces, if a message X has been sent, then somewhere in the future on that trace message Y will be received [PS25]. frequently occurring syntactic defects. 	 Use model checking techniques to analyze the possible interaction traces and identify patterns of common interactive behaviour. During this process, detect possible ambiguities in the CS sequence diagram. Apply a series of checks to identify other syntactic defects in the CS.
M4	<i>Input</i> : a CS	 Check well-formedness of each individual CS entity using the consistency rules.

	Oraclebasedon:consistencyrulesforindividualdesignentitiesandconsistencyrulestracerelationsacrossvariousdesignentities.InthepaperPS5]thesearedefined.defined.Input:a CSOraclebasedon:24consistencyrulesbasedontheneedsofindustrialpartners[PS11].	 Check relationships across entities, e.g. if an entity X requires some other entity Y, the entity Y should be defined some where in the design, else the design is inconsistent If a CS element is created, for every rule related to the element, a new instance of the rule is created and evaluated. If a CS element was deleted, all intances of the element rule are destroyed. For every rule instance of a changed element, an evaluation
		of the rules is performed.
M5	<i>Input</i> : a CS <i>Oracle based on</i> : Predefined OCL constraints for quality of CS and/or wellformedness (syntax, basic properties, naming, best practices [PS1, PS12, PS13]	Compare the CS class diagram with the OCL constraints for detecting defects.
	<i>Input</i> : a CS <i>Oracle based on</i> : OCL invariant constraints for general well-formedness of CSs[PS7]	 For each constraint, create an ATL transformation rule. Then, check the constraints by using ATL transformation
	<i>Input</i> : a CS with OCL constraints <i>Oracle based on</i> : the properties that come with the CS [PS8, PS27]	Class diagrams and OCL constraints of the CS are translated into a constraint satisfaction problem and solved with different tools.
M6	Input: a CS Human oracle using: Requirement specifications [PS2], set of heuristics based on practice experience [PS6, PS17], faults in the source code [PS15], defined collection of rules and/or metrics [PS17, PS18, PS22], list of previously identified defects [PS19]	Realize a manual inspection (or alike) on the determined artefact.
M7	<i>Input</i> : a CS <i>Oracle based on</i> : graph transformation rules that express CS inconsistency detection and resolution [PS20].	 Generate graphs from CS. Apply the technique of critical pair analysis by using the transformation rules. Analyse potential dependencies between detection and resolution of the possible inconsistencies found in the CS.
M8	 Input: CS class diagram with constraints [PS24]. Oracle based on: minimum cardinalities to evaluate the consistency of UML class. cardinality is inconsistent if it can have differing 	 Transform the CS class diagram in a graph with nodes (class), edges (relationships) and a set of edge information (relation type and constraints). Then, divide the graph into subgraphs in order to evaluate the relation cardinality.

⁵ http://www.sdmetrics.com/

	values within the same	
M9	subgraph. Input: CS with associated constraints [PS4]. Oracle based on: multiplicities, generalizations and OCL constraints to assess the inconsistencies between class diagram and collaboration diagrams.	 Set the test criteria (i.e. association-end multiplicity, generalization, class attributes). Create a test set in a formal semantic. Determine variables values from class diagrams. Determine paths from collaboration diagrams. Exercise scenarios to evaluate the constraints.
M10	<i>Input</i> : CS with constraints [PS10]. <i>Oracle based on</i> : test input constraints generates from the paths of a Variable Assignment Graph to assess the consistency between different views and constraints based on requirements.	 Set the test adequacy criteria (i.e. all message coverage, condition coverage and all message path coverage) Transform the CS in a executable form (DUT) by using Java-like Action Language format. Test inputs are derived from DUT by using a Variable Assignment Graph. Exercise the executable form of a DUT with test inputs.
M11	 Input: CS with OCL constraints [PS21]. Oracle based on: OCL pre-conditions, post-conditions and invariants that come with the CS to assess inconsistencies. a set of heuristics that are necessary for the construction of verifiable OCL expressions 	 Build a Testable Aggregate Model (TAM) by combining information from the class diagram, sequence diagram and OCL information of the CS. Generate the test cases and input values. Then, the TAM is evaluated by using a symbolic execution. Finally, the tool USE is used for parsing and validating OCL expressions.

	(defined in USE6 tool)			
	Input: a CS activity diagram	1. CS activiy diagram is parsed and		
	[PS28]	initialized semantically with		
		concrete data.		
	Oracle based on: path	2. The model is symbolically		
	conditions and input values are used to find the	executed, to collect paths, input variables, and their path		
	inconsistency between the	conditions.		
	design and implementation.	3. Then, the path conditions are passed to a constraint solver to		
		generate a set of concrete value		
		of possible input variables.		
		4. Finally, the generated concrete		
		input variables are semantically		
		executed on the model to		
N/10		identify the defects.		
M12	Input: a CS with OCL	1. Transforms a CS class diagram		
	constraints [PS3].	into test data for the logical animation.		
	Oracle based on: the OCL	2. The constraints defined in a class		
	constraints that come with	diagram are transformed into		
	the CS to assess if the CS	SQL queries into a Java class		
	meets the user's	called TestCases.		
	requirements.	3. JUnit tool is used to run these		
		test cases.		

In Table IX, we can see that the class diagram (CD) is used in most primary studies (86%), which suggests that the structural part of the CS is the part most often used for detecting defects. The second most used is the sequence diagram (SD) in 46% of the primary studies, followed by the state machine (STDM) and activity diagrams (AD) that are used in 36% and 25% of the primary studies respectively (see Fig. 5). This confirms that these four diagrams are the most frequently used to specify both the structural and behavioural part of a CS Techniques used as defect detection mechanism.

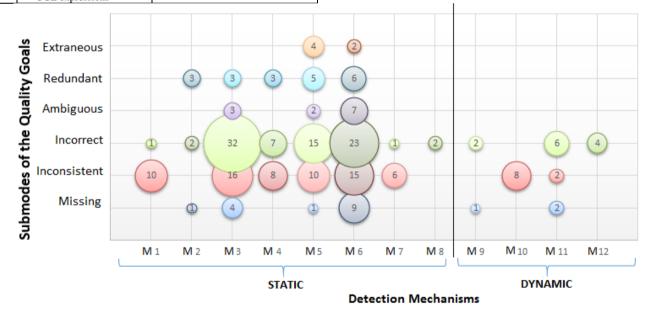
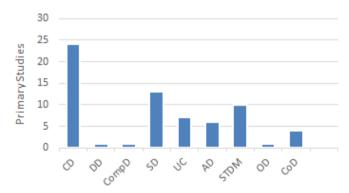


Fig. 4. Number of defects grouped by Detection Mechanism and Sub mode of the QGs

Tech-	DM	Туре	Tool UML		Diagrams	Ref.
nique		~ 1		Struc	Behaviou	1
_				tural	ral	
	M1	А	RACOoN	CD	SD, CoD, STMD	PS26
	MO	_	EmcMC	CD	STMD	0022
	M2	M/A	EinaGMC Design	CD CD	- UC, AD,	PS23 PS6
	M3	M/A	Advisor	-	CoD, SD	
			FXU	CD	STMD	PS9
			UMLint	CD	UC	PS14
			SDMetrics, SAAT	CD	UC, SD	PS16*
			SquAT	CD	SD	PS25
	M4		Eclipse plug-	CD,	UC, SD,	PS5
		_	in	DD	STMD	
		(¥		Com		
) pa		pD		
		Automated (A)	UML/	CD	SD,	PS11
		ton	Analyzer		STMD	
	M5	Au	Eclipse-based Plug-in	CD	-	PS7
tic			UMLtoCSP	CD	-	PS8
Static			USE	CD.	UC, SD,	PS13
			0.02	OD	CoD,ST	1010
					MD, AD	
			Executable OCL checker	-	AD	PS27
			-	CD	UC , SD,	PS12
			-	CD	STMD	1512
			-	CD	-	PS1
	M6		-	-	STDM	PS2
		M) [-	-	AD	PS15
		Manual (M)	-	CD	UC, SD, STMD	PS17
			-	CD	SD, STMD	PS18
			-	CD	-	PS19
			-	CD	SD	PS22
	M7	А	AGG	CD	STMD	PS20
	M8	М	-	CD	-	PS24
	M9		-	CD	CoD	PS4
nic	M10	A	Eclipse Plug- in, USE	CD	SD, AD	PS10
Dynamic	M11	1	USE, ADAPTUML	CD	SD	PS21
A			ADSim	-	AD	PS28
	M12	1	JUnit	CD	-	PS3



UML diagrams used in the Conceptual Schemas

Fig. 5. Diagrams reported in the pimary studies

In order to compare the coverage of the detection mechanisms, the defect data was grouped by detection mechanism and by the causes at fine-grained level (sub modes) for CSs defects. From this data (see Fig. 4) we can see (by column) that M3, M5 and M6 to some extent tried to cover all the causes (six sub modes) of the defects reported in the papers analysed, while this is not the case for M8 and M12, which cover only one defect cause. The figure also reveals (by row) that the cause of the Incorrect sub-mode is covered by almost all mechanisms (11), followed by Inconsistent (8) and Missing (6). This is not surprising, as the main QGs pursued in such artefacts are Correctness, Completeness and Consistency [5]. Finally, whereas the primary studies analysed mainly report both correctness and consistency defects in CSs by assessing their structural properties, the dynamic mechanisms are not being fully exploited (few defects reported with these mechanisms) as testing and debugging tools in the quality assurance process of conceptual schemas.

In order to answer the second part of our research question (location of the defects) we identified the modelling element it was located in. For this we used the UML terminology [2] to distinguish 100 different elements. In Table X we can see that the modelling elements most reported in the primary studies (i.e. number of references per element) are Operation (33 references, 8%) and Class (27 references, 10%).

TABLE X.	MODELLING ELEMENTS

Modelling Element	# Defects	# Refs
Action	1	1
Activity	1	1
Actor	2	2
Association	6	7
Class	10	27
Comment	1	2
Connector	3	6
Constraint	5	14
ControlNode	1	1
DecisionNode	1	2
Diagram	3	3
Feature	1	2
Generalization	12	21
InstanceSpecification	2	10
Interface	2	3
Lifeline	1	1
Link	1	1
Message	1	1
MessageOccurrenceSpecification	1	1
MultiplicityElement	3	7
NamedElement	3	19
Operation	8	33
Package	1	1
Property	11	16
ProtocolTransition	1	3
Pseudostate	1	1
Region	1	2
RelationShip	1	5
State	4	8
Transition	3	10
UseCase	2	5
ValueSpecification	2	2
VisibilityKind	4	8
Total	100	226

TABLE IX. TECHNIQUES USED AS DEFECT DETECTION MECHANISM

The study also found that Generalization is the most affected modelling element (12 defects, or 12%) by defects reported, followed by the Property and Class elements with 11 and 10 defects, respectively. This is possibly because these are the modelling elements that most occur in a structural diagram.

VI. LIMITATIONS OF THE STUDY

In the process of conducting our mapping study, we faced various limitations related to the selection of relevant studies and accuracy of the data extraction, such as the following:

Other terms such as "bug", and "error" were not considered because they are most used at code level. This was confirmed by including the terms in the search string and confirming that the papers contained no defects.

Since primary studies are mostly focused on presenting a detection mechanism rather than reporting a complete list of the defects found by this mechanism, the defect list most frequently reported in the literature is not entirely equivalent to the number of defects found in CSs. Another limitation could arise from our categorizations and its completeness for analysis, a validity threat common to mapping studies. We follow a methodology proposed in the literature [5] to create the classification scheme and the scheme attributes are based mainly on the IEEE standard [8].

Regarding the accuracy of the data extraction; several articles did not given sufficient information regarding the attributes considered for describing defects (e.g. severity and priority).

VII. CONCLUSIONS AND FUTURE WORK

This paper describes a systematic mapping study of the defect types reported on in CSs represented with UML and the techniques used to detect them. The results are summarized below.

RQ1: What defects in UML-based CSs are reported in the literature? We identified the defect types relevant to CSs by a defect classification scheme. This classification is clearly differentiated from others (e.g. defects at level code) by not considering problems related for instance to user interface and input/output crash.

Although several categories can be obtained (e.g. by severity, by defect cause, by priority), in this study our analysis was mainly carried out based on defect causes that affected quality goals defined for CSs in an MDD context [4]. We found there is a tendency to report only defect types related to the "Wrong" type (e.g. incorrect) rather than the "Missing" or "Unnecessary" types.

On the other hand, few papers reported other important aspects of the defects, such as severity (i.e. [PS7], [PS9]). No paper reported the priority of defects, which could be due to several reasons. It is possible that the complexity of managing the impact of defects on the quality of the different CS makes it difficult to specify values for these attributes, i.e. the lack of a history of defects makes it difficult to establish their severity and priority. These findings indicate that more research is needed to better understand the severity and priority of defects with respect to their impact on the quality properties.

RQ2: How and where have these defects been detected? We identified some of the techniques used for detecting defects. However, the evidence from this review suggests that the main emphasis is on the use of techniques based on static analysis of the CS, which does not require the execution of the model, so that only part of the specification can be analysed.

Performing a systematic mapping study is time-consuming and interpreting the results is not easy. However, the main benefits are that it provides conclusions, new insights and identifies research gaps.

After analysing the results of the review, we can draw the conclusion that although there are several studies aimed at reporting defect types at the CS level, a complete, well-documented (e.g. based on defect classification scheme) and evaluated list is still lacking. This information should include an analysis of the severity of the defects with respect to their impact on the quality properties of CS and the priority in solving them.

To date, defect types appear to be poorly used since most of them are used primarily to verify the *Correctness* and *Comprehensibility* of a CS by static detection techniques. Therefore, more efforts (e.g. by using dynamic techniques such as testing) are required to detect other defect types at the conceptual schema level and to exploit the information contained in them e.g. to measure the efficiency and effectiveness of verification⁷ & validation⁸ tools with respect to the number and type of defects that they manage. Additionally, with this information the defects detected in an MDD environment could be tracked, reduced and resolved.

One of the challenges involved in this review was developing an appropriate defect classification scheme for CSs. Although we have gone through a couple of revisions throughout the study, we found that our final classification scheme is highly usable and complete for our mapping.

This systematic mapping study is a part of a more extensive research work, whose principal goal is to propose an approach for testing-based conceptual schema validation in a Model-Driven Environment [18], [19]. To reach that goal, further research is needed. First, we need to clarify which defect types can be found with testing techniques. Second, we need to know which parts of a CS are expected to be most defect-prone. Third, we need to prioritize defects types that are expected to appear most often during testing activities. Finally, we need to develop a testing solution and evaluate it by and deploying it in an MDD environment.

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⁷ Verification is to check that the CS meets its stated functional and non-functional requirements [26].

⁸ Validation is to ensure that the CS meets the customer's expectations [26].

APPENDIX I

 TABLE XI.
 Compliance of our proposed classification scheme with IEEE std. 1044

		<u> </u>
IEEE Std. 1044	Definition	Our
Defect ID	Unique identifier for the failure.	Proposal Defect ID
Description	Description of what is missing, wrong, or	Description
Description	unnecessary.	Description
Status		
Asset	Current state within defect report life cycle.	n/a D:
Asset	The software asset (product, component,	Diagram
	module, etc.) containing the defect.	Туре
Artefact	The specific software work product	Modelling
X 7 ·	containing the defect.	Element
Version	Identification of the software version in	References
Detected	which the defect was detected.	,
Version	Identification of the software version in	n/a
Corrected	which the defect was corrected.	
Priority	Ranking for processing assigned by the	Priority
	organization responsible for the evaluation,	
	resolution, and closure of the defect relative	
<i>a</i>	to other reported defects.	<i>a</i>
Severity	The highest failure impact that the defect	Severity
	could (or did) cause, as determined by	
	(from the perspective of) the organization	
	responsible for software engineering.	
Probability	Probability of recurring failure caused by	n/a
	this defect.	
Effect	The class of requirement that is impacted by	n/a
	a failure caused by a defect.	D:
Туре	A categorization based on the class of code	Diagram
	within which the defect is found or the	level
	work product within which the defect is	
	found.	
Mode	A categorization based on whether the	Defect
	defect is due to incorrect implementation or	Cause
	representation, the addition of something	
	that is not needed, or an omission.	
Insertion	The activity during which the defect was	n/a
Activity	injected/inserted (i.e., during which the	
	artifact containing the defect originated).	-
Detection	The activity during which the defect was	Detection
Activity	detected (i.e., inspection or testing).	Mechanism
Failure	Identifier of the failure(s) caused by the	n/a
Reference(s)	defect.	
Change	Identifier of the corrective change request	n/a
Reference	initiated to correct the defect.	
Disposition	Final disposition of defect report upon closure.	n/a
-		Technique
		Purpose Technique
-		
		Type Tool
-		
		Support

APPENDIX II

TABLE XII. LIST OF PRIMARY STUDIES INCLUDED IN THE REVIEW

Ref	Source				
[PS1]	Aguilera, D., Gómez, C., Olivé, A., Enforcement of Conceptual				
	Schema Quality Issues in Current Integrated Development				
	Environments. In CAiSE 2013, Valencia, Spain (2013).				
[PS2]	Ali, S., Yue, T., Malik, Z.: Comprehensively evaluating conformance error rates of applying aspect state machines. In : Proceedings of the 11th annual international conference on Aspect-oriented Software Development, pp.155-166 (2012)				

[PS3]	Aljumaily, H., Cuadra, D., Martinez, P.: Applying black-box
	testing to UML/OCL database models. Software Quality Journal
	22(2), 153-184 (2014)
[PS4]	Andrews, A., France, R., Ghosh, S., Craig, G.: Test adequacy
	criteria for UML. Software Testing Verification and Reliability
	13(2), 95-127 (2003)
[PS5]	Bellur, U., Vallieswaran, V.: On OO design consistency in
	iterative development. In IEEE, ed. : in ITNG '06, pp.46-51
EDG(c)	
[PS6]	Berenbach, B.: The evaluation of large, complex UML analysis
	and design models. In Society, I., ed. : in Proceedings ICSE '04, pp.232-241 (2004)
[PS7]	Bezivin, J., Jouault, F.: Using ATL for checking models.
[137]	Electronic Notes in Theoretical Computer Science 1(2), 70-118
	(2006)
[PS8]	Cabot, J., Clarisó, R., Riera, D.: Verification of UML/OCL Class
[100]	Diagrams using Constraint Programming. In Proceedings
	ICSTW '08, 73-80 (2008)
[PS9]	Derezinska, A., Pilitowski, R.: Correctness issues of UML Class
	and State Machine Models in the C# Code Generation and
	Execution Framework. In Proceedings IMCSIT'2008.
[PS10]	Dinh-Trong, T., Ghosh, S., France, B.: A Systematic Approach
	to Generate Inputs to Test UML Design Models. In Proceedings
	ISSRE, 95-104 (2006)
[PS11]	Egyed, A.: Instant consistency checking for the UML. In
	Proceedings ICSE '06, Shanghai, China, pp.381-390 (2006)
[PS12]	Gomaa, H., Wijesekera, D. : Consistency in multiple-view UML
	models: a case study. In IEEE, ed. : in Proceedings of the
	Workshop on Consistency Problems in UML-based Software
(DC12)	Development II, San Francisco, Calif, USA, pp.1-8 (2003)
[PS13]	Ha, I., Kang, B.: Meta-Validation of UML Structural Diagrams and Behavioral Diagrams with Consistency Rules.
	and Behavioral Diagrams with Consistency Rules. Communications, Computers and Signal Processing 2, 679-683
	(2003)
[PS14]	Hasker, R. W., Rowe, M., UMLint: Identifying defects in UML
[101]	diagrams, <i>in ASEE' 2011</i> , Vancouver, BC, Canada, 2011.
[PS15]	Holt, N. E., Briand, L. C., Torkar, R.: Empirical evaluations on
	the cost-effectiveness of state-based testing: An industrial case
	study. Inf. and Software Technology 56(8), 890-910 (2014)
[PS16]	Lange, C., Chaudron, M. : Defects in industrial UML models-a
	multiple case study. In Proceedings QiM '07, Nashville, Tenn,
	USA, pp.50-79 (2007)
[PS17]	Lange, C., Chaudron, M.: An empirical assessment of
	completeness in UML designs. In IEEE, ed. : in Proceedings
(DC101	EASE '04, pp.111-121 (2004) Lange, C., Chaudron, M., Muskens, J., Somers, L., Dortmans, H.:
[PS18]	
	An empirical investigation in quantifying inconsistency and incompleteness of uml designs. In : Proc. Workshop on
	Consistency Problems in UML-based Software Development,
	6th International Conference on Unified Modelling Language,
	UML 2003, San Francisco, USA (2003)
[PS19]	Leung, F., Bolloju, N.: Analyzing the Quality of Domain Models
	Developed by Novice Systems Analysts. In Proceedings
	HICSS'2005, Hawaii, pp.1-7 (2005)
[PS20]	Mens, T., Van Der Straeten, R., D'Hondt, M.: Detecting and
	resolving model inconsistencies using transformation
	dependency analysis. In MoDELS 2006 4199 of LNCS, 200-214
	(2006)
[PS21]	Pilskalns, O., Andrews, A., Knight, A., Ghosh, S., France, R.:
	Testing UML designs. In : Information and Software
(DCIAA)	Technology, MA, USA (2007)
[PS22]	Pilskalns, O., Williams, D., Aracic, D., Andrews, A.: Security
	consistency in UML designs. In : COMPSAC '06. 30th Annual
	International Computer Software and Applications Conference, Chicago II, pp 251, 258 (2006)
	Chicago, IL, pp.351 - 358 (2006) Queralt, A., Teniente, E.: Verification and validation of UML
[D\$22]	
[PS23]	
[PS23]	conceptual schemas with OCL. ACM Transactions on Software
	conceptual schemas with OCL. ACM Transactions on Software Engineering and Methodology (2012)
[PS23] [PS24]	conceptual schemas with OCL. ACM Transactions on Software Engineering and Methodology (2012) Satish, S. S., Shashikant, S. R., Sambhe, V. K., Shelke, R. B.,
	conceptual schemas with OCL. ACM Transactions on Software Engineering and Methodology (2012)

	Conference and Workshop on Emerging Trends in Technology, pp.222-223 (2010)
[PS25]	Van Amstel, M. F., Lange, C. F. J., Chaudron, M. R. V.: Four Automated Approaches to Analyze the Quality of UML Sequence Diagrams. In Proc. COMPSAC 2007, pp.415-424 (2007)
[PS26]	Van Der Straeten, R.: Inconsistency Management in Model- Driven Engineering. An Approach using Description Logics PHD Thesis ed. Faculty of Science, Brussels (2005)
[PS27]	Yin, L., Liu, J., Li, X.: Validating requirements model of a B2B system. In : ICIS 2009. Eighth IEEE/ACIS International Conference on Computer and Information Science, Shanghai, pp.1020 - 1025 (2009)
[PS28]	Yu, L., X., T., L., W., X., L.: Simulating software behavior based on UML activity diagram. In : Proceedings of the 5th Asia-Pacific Symposium on Internetware (2013)

APPENDIX III

 TABLE XIII.
 PARTIAL OVERVIEW OF THE DEFECTS LIST REPORTED IN THE MAPPING STUDY

Mode	Defect ID	Description	Modelling Element	Tech- nique Type	Ref.
Missing	D1.1	Missing Class specification	Class	Static	PS16
50	D2.1	Inconsistent Operation access permissions	Visibility Kind	Static and Dyna mic	PS21 PS22
Wrong	D3.21	Incorrect Multiplicity definition	Multiplicity Element	Static	PS14 PS19 PS24
	D4.2	Ambiguous Discriminator Constraint	Generalization	Static	PS19
essary	D5.11	Redundant Constraint	Constraint	Static	PS8 PS23
Unnecessary	D6.3	Extraneous Too many attributes	Property	Static	PS1

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